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# **FAST GATE TURN-OFF THYRISTORS**

Thyristors in TO-220AB envelopes capable of being turned both on and off via the gate. They are suitable for use in high-frequency inverters, resonant power supplies, motor control, horizontal deflection systems etc. The devices have no reverse blocking capability. For reverse blocking operation use with a series diode, for reverse conducting operation use with an anti-parallel diode.

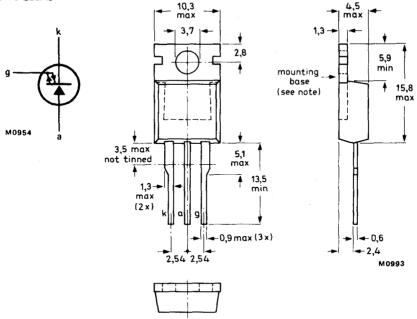
### QUICK REFERENCE DATA

			BTW58-1000R	1300R	1500R	
Repetitive peak off-state voltage	$v_{DRM}$	max.	1000	1300	1500	٧
Non-repetitive peak on-state current	<sup>I</sup> TSM	max.		50		Α
Controllable anode current	TCRM	max.		25		Α
Average on-state current	<sup>1</sup> T(AV)	max.		6.5		Α
Fall time	tf	<		250		ns

### **MECHANICAL DATA**

Dimensions in mm

Fig.1 TO-220AB



Net mass: 2 q

Note: The exposed metal mounting base is directly connected to the anode.

Accessories supplied on request: see data sheets Mounting instructions and accessories for TO-220 envelopes.



**RATINGS** 

Limiting values in accordance with the Absolute Maximum System (IEC134)

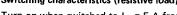
Anode to cathode			BTW58-100	00R (	1300R	1500R	
Transient off-state voltage	V <sub>DSM</sub>	max.	. 120	00	1500	1650	V*
Repetitive peak off-state voltage	VDRM	max.	100	00	1300	1500	V*
Working off-state voltage	$v_{DW}$	max.	69	50	1200	1300	V*
Continuous off-state voltage	$v_D$	max.	6	50	750	800	V*
Average on-state current (averaged 20 ms period) up to Tmb = 85 °C			<sup>I</sup> T(AV)	max	x.	6.5	Α
Controllable anode current			ITCRM	max	x.	25	Α
Non-repetitive peak on-state curre t = 10 ms; half-sinewave;	nt						
T <sub>j</sub> = 120 °C prior to surge			TSM	ma	х.	50	Α
$1^2$ t for fusing; t = 10 ms			l²t	max	х.	12.5	A²s
Total power dissipation up to $T_{ml}$	<sub>b</sub> = 25 °C		P <sub>tot</sub>	ma	×.	65	W
Gate to cathode							
Repetitive peak on-state current $T_j = 120$ °C prior to surge gate-cathode forward; t = 10 ms	v half einm	Menvo	locu	ma		25	Α
gate-cathode reverse; $t = 20 \mu s$	s, nam-sinev	wave	<sup>I</sup> GFM <sup>I</sup> GRM	ma		25 25	Â
Average power dissipation (average	ed over any	ď	GRIVI				
20 ms period)	04 0 VO. U	,	PG(AV)	max	x.	2.5	W
Temperatures							
Storage temperature			$T_{stg}$		-40 t	o +150	oC
Operating junction temperature			$\tau_{j}$	ma	х.	120	οС
THERMAL RESISTANCE							
From junction to mounting base			R <sub>th j-mb</sub>	==		1.5	K/W
From mounting base to heatsink with heatsink compound			R <sub>th mb-h</sub>	=		0.3	K/W
with 56367 alumina insulator a heatsink compound (clip-moun			R <sub>th mb-h</sub>	=		0.8	Κ/W

<sup>\*</sup>Measured with gate-cathode connected together.

### **CHARACTERISTICS**

Δn	aho	to	cath	ode

Anode to cathode				
On-state voltage $I_T = 5 \text{ A}$ ; $I_G = 0.2 \text{ A}$ ; $T_j = 120 \text{ °C}$	$v_{T}$	<	3.0	V*
Rate of rise of off-state voltage that will not trigger any off-state device; exponential method $V_D = 2/3 \ V_{Dmax}; V_{GR} = 5 \ V; T_j = 120 \ ^{\circ}C$	dV <sub>D</sub> /dt	<	10	kV/μs
Rate of rise of off-state voltage that will not trigger any device following conduction, linear method I <sub>T</sub> = 5 A; V <sub>D</sub> = V <sub>DRMmax</sub> ; V <sub>GR</sub> = 10 V; T <sub>j</sub> = 120 °C	dV <sub>D</sub> /dt	<	1.5	kV/μs
Off-state current V <sub>D</sub> = V <sub>Dmax</sub> ; T <sub>j</sub> = 120 °C	ID	<	3.0	mA
Latching current; T <sub>j</sub> = 25 °C	IL	typ.	1.0	A**
Gate to cathode				
Voltage that will trigger all devices $V_D = 12 \text{ V}; T_j = 25 ^{\circ}\text{C}$	$v_{GT}$	>	1.5	V
Current that will trigger all devices $V_D = 12 \text{ V}; T_j = 25 ^{\circ}\text{C}$	I <sub>GT</sub>	>	200	mA
Minimum reverse breakdown voltage IGR = 1.0 mA	V <sub>(BR)GR</sub>	>	10	V
Switching characteristics (resistive load)				
Turn-on when switched to $I_T = 5$ A from $V_D = 250$ V with $I_{GF} = 0.5$ A; $T_j = 25$ °C				
delay time	t <sub>d</sub>	<	0.25	μs



delay time rise time

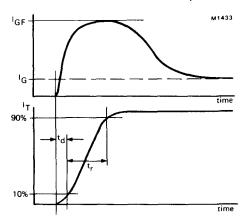


Fig.2 Waveforms

μs

1.0

- Measured under pulse conditions to avoid excessive dissipation.
- \*\* Below latching level the device behaves like a transistor with a gain dependent on current.

## Switching characteristics (inductive load)

Turn-off when switched from I 
$$_T$$
 = 5 A to V $_D$  = V $_D$ RMmax, V $_G$ R = 10 V; L $_G$   $\leq$  1.0  $\mu$ H; L $_S$   $\leq$  0.25  $\mu$ H; T $_j$  = 25 °C storage time t $_f$   $<$  0.5  $\mu$ s fall time t $_f$   $<$  0.25  $\mu$ s peak reverse gate current I $_G$ R  $<$  6 A

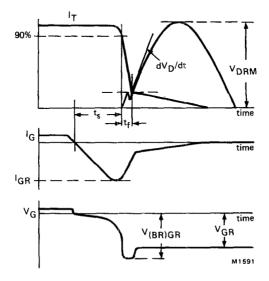


Fig.3 Waveforms,

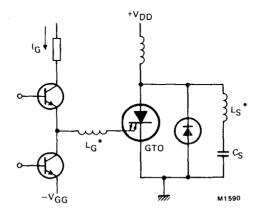


Fig.4 Inductive load test circuit

<sup>\*</sup>Indicates stray series inductance only.

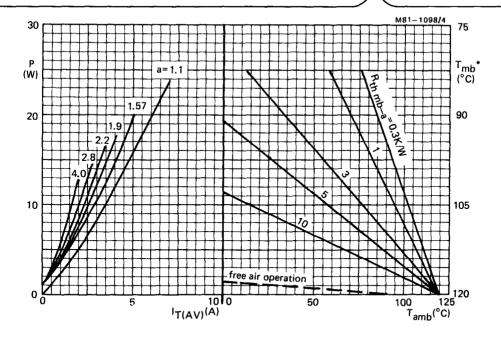


Fig.5 The right-hand part shows the interrelationship between the power (derived from the left-hand part) and the maximum permissible temperatures.

$$a = form factor = \frac{IT(RMS)}{IT(AV)}$$

P = power excluding switching losses.

 $<sup>^*</sup> T_{mb}$  scale is for comparison purposes and is correct only for R  $_{th\ mb\text{-}a} \! < \! 9.6$  K/W.

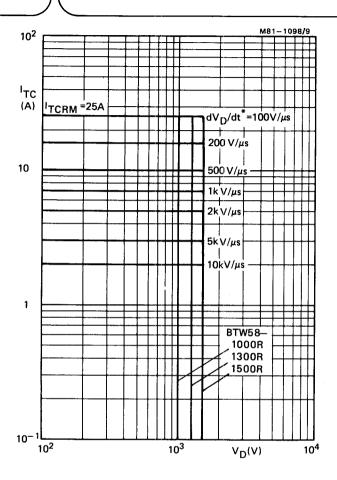


Fig.6 Anode current which can be turned off versus anode voltage; inductive load; VGR = 10 V; LG  $\leq$  1.0  $\mu\text{H}$ ; LS  $\leq$  0.25  $\mu\text{H}$ ; T $_{j}$  = 85 °C. \*dVD/dt is calculated from IT/CS.

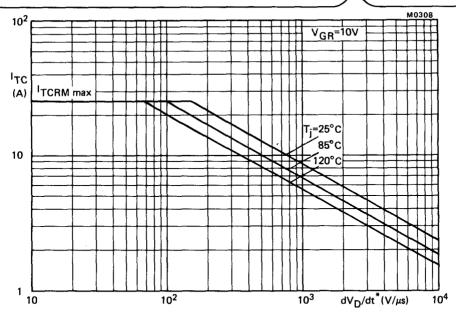


Fig.7 Anode current which can be turned off versus applied  $dV_D/dt^*$ ; inductive load;  $V_{GR} = 10 \text{ V}$ ;  $L_G \le 1.0 \ \mu\text{H}$ ;  $L_S \le 0.25 \ \mu\text{H}$ . \* $dV_D/dt$  is calculated from  $l_T/C_S$ .

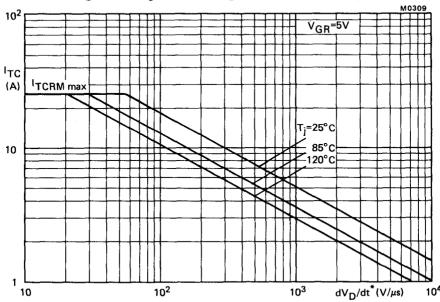


Fig.8 Anode current which can be turned off versus applied  $dV_D/dt^*$ ; inductive load;  $V_{GR}$  = 5 V;  $L_G \le 1.0 \ \mu H$ ;  $L_S \le 0.25 \ \mu H$ . \* $dV_D/dt$  is calculated from  $I_T/C_S$ .

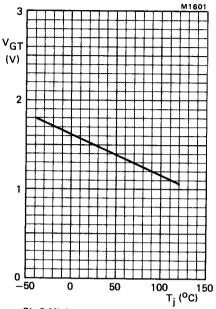


Fig.9 Minimum gate voltage that will trigger all devices as a function of junction temperature;  $V_D = 12 \text{ V}$ .

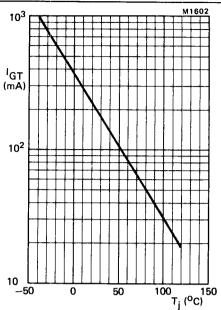


Fig.10 Minimum gate current that will trigger all devices as a function of junction temperature; V<sub>D</sub> = 12 V.

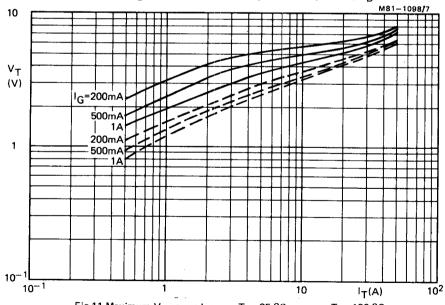


Fig.11 Maximum  $V_T$  versus  $I_T$ ; ----  $T_j$  = 25 °C; ---  $-T_j$  = 120 °C.

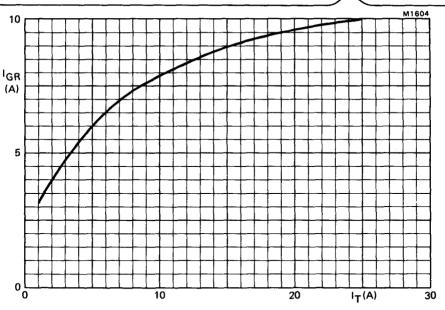


Fig.12 Peak reverse gate current versus anode current at turn-off; inductive load; VGR = 10 V; IG = 0.2 A; LG = 0.8  $\mu$ H; T $_i$  = 120 °C; maximum values.

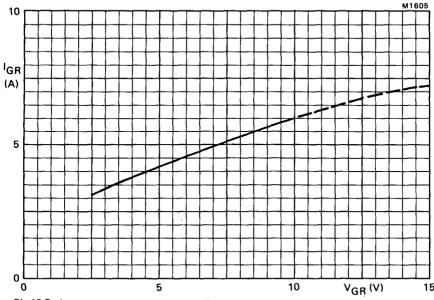


Fig.13 Peak reverse gate current versus applied reverse gate voltage; inductive load;  $I_T$  = 5 A;  $I_G$  = 0.2 A;  $L_G$  = 0.8  $\mu$ H;  $T_j$  = 120 °C; maximum values.

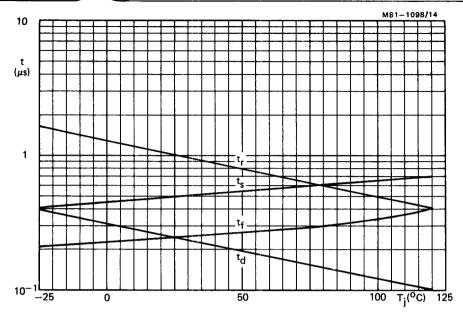


Fig.14 Switching times as a function of junction temperature; V  $_D \geqslant$  250 V; I  $_T$  = 5 A; I  $_GF$  = 0.5 A; V  $_GR$  = 10 V; I  $_G$  = 0.2 A; L  $_G$  = 0.8  $\mu\text{H}$ ; maximum values.

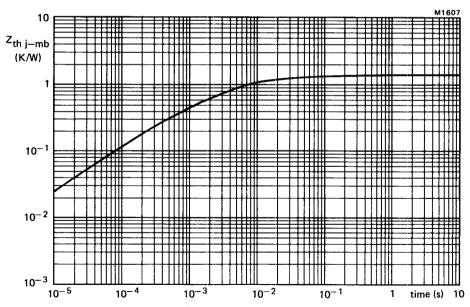


Fig.15 Transient thermal impedance.

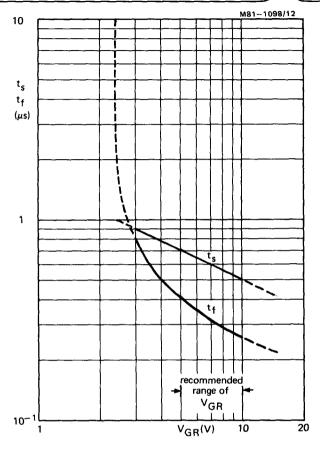


Fig.16 Storage and fall times versus applied reverse gate voltage; inductive load;  $I_T$  = 5 A;  $I_G$  = 0.2 A;  $L_G$  = 0.8  $\mu$ H;  $T_j$  = 25 °C; maximum values.

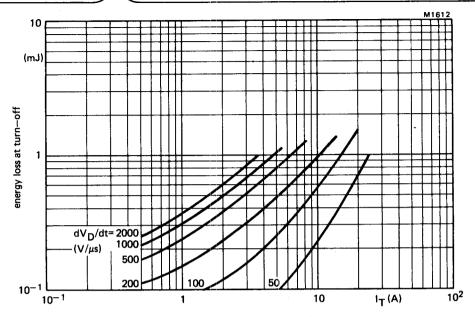


Fig.17 Maximum energy loss at turn-off (per cycle) as a function of anode current and applied dVD/dt (calculated from IT/CS); reapplied voltage sinsusoidal up to VDRM = 1200 V; VGR = 10 V; IG = 0.2 A; LG  $\leq$  1.0  $\mu$ H; LS  $\leq$  0.25  $\mu$ H; Tj = 120 °C.

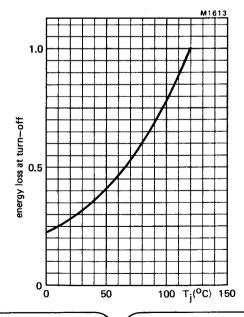


Fig.18 Energy loss at turn off as a function of junction temperature; I  $_G$  = 0.2 A; V  $_{G\,R}$  = 10 V. Normalised to T  $_j$  = 120 °C.